## Search Notes



Application/Control No.

Applicant(s)/Patent Under Reexamination

09960080

**THOMAS** 

Examiner

Nawaz, Asad M

Art Unit 2155

Notes	Date	Exa	aminer
East Search (USPAT; USPGPUB; EPO; JPO; DERWENT; BM TDB)	7/23/06	AMN	
Jpdated PGPUB Search	7/23/06	AMN	
nventor Name search for ODP	7/23/06	AMN	
NPL Search (IEEE, ACM, Google Scholar)	7/23/06	AMN	
Consulted Primary Examiner Yves Dalencourt regarding allowability and classification	7/18/06	AMN	
Consulted Primary Examiner Phillip Tran regarding allowability	7/19/06	AMN	
consulted Primary Examiner Patrice Winder regarding search trategy, classification, and allowablility	7/20/06	AMN	
onsulted Primary Examiner Eliseo Ramos Feliciano regarding earch strategy, classification, and allowability	7/20/06	AMN	
Consulted SPE Duc Nguyen regarding allowability	7/20/06	AMN	
Consulted SPE Saleh Najjar regarding allowability	7/20/06	AMN	
U.S. Patent and Trademark Office		Part of Paper No.: 2	0060724

## Interference Searched



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	Class	SubClass	Date		Examiner
709		220, 250	7/23/06	AMN	
455		426.2	7/23/06	AMN	

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Class	SubClass	Date	ļ	Examiner
709	202-211, 217-238, 250	7/23/06	AMN	
455	426.2-433	7/23/06	AMN	
340	3.1	7/23/06	AMN	